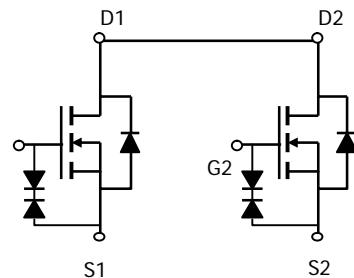
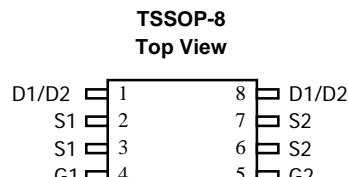


Dual N-Channel Enhancement Mode MOSFET

FEATURES

 $V_{DS} (V) = 20V$
 $I_D = 6A (V_{GS} = 4.5V)$
 $R_{DS(ON)} < 22m\Omega (V_{GS} = 4.5V)$
 $R_{DS(ON)} < 30m\Omega (V_{GS} = 2.5V)$

ESD Rating: 2000V HBM

8810
N-Channel MOSFET

Absolute Maximum Ratings $T_A=25^\circ C$ unless otherwise noted

| Parameter | Symbol | Maximum | Units |
|--|----------------|------------|-------|
| Drain-Source Voltage | V_{DS} | 20 | V |
| Gate-Source Voltage | V_{GS} | ± 8 | V |
| Continuous Drain Current ^A | I_D | 6 | A |
| Pulsed Drain Current ^B | I_{DM} | 30 | |
| Power Dissipation ^A | P_D | 1.5 | W |
| Junction and Storage Temperature Range | T_J, T_{STG} | -55 to 150 | °C |

Thermal Characteristics

| Parameter | Symbol | Typ | Max | Units |
|--|-----------------|-----|-----|-------|
| Maximum Junction-to-Ambient ^A | $R_{\theta JA}$ | 64 | 83 | °C/W |
| Maximum Junction-to-Ambient ^A | | 89 | 120 | °C/W |
| Maximum Junction-to-Lead ^C | $R_{\theta JL}$ | 53 | 70 | °C/W |

8810 Electrical Characteristics (TA=25°C, unless otherwise noted)

| Symbol | Parameter | Conditions | Min | Typ | Max | Units |
|-----------------------------|---------------------------------------|---|-----|------|-----|-------|
| STATIC PARAMETERS | | | | | | |
| BV _{DSS} | Drain-Source Breakdown Voltage | I _D =250μA, V _{GS} =0V | 20 | | | V |
| I _{DSS} | Zero Gate Voltage Drain Current | V _{DS} =16V, V _{GS} =0V | | | 1 | μA |
| I _{GSS} | Gate-Body leakage current | V _{DS} =0V, V _{GS} =±12V | | | ±15 | μA |
| V _{GS(th)} | Gate Threshold Voltage | V _{DS} =V _{GS} I _D =250μA | 0.5 | 0.6 | 1 | V |
| I _{D(ON)} | On state drain current | V _{GS} =4.5V, V _{DS} =5V | 30 | | | A |
| R _{DS(ON)} | Static Drain-Source On-Resistance | V _{GS} =4.5V, I _D =6A | | 20 | 22 | mΩ |
| | | V _{GS} =2.5V, I _D =5.5A | | 28 | 30 | mΩ |
| g _{FS} | Forward Transconductance | V _{DS} =5V, I _D =6A | | 29 | | S |
| V _{SD} | Diode Forward Voltage | I _S =1.5A, V _{GS} =0V | | | 1.2 | V |
| I _S | Maximum Body-Diode Continuous Current | | | | 2.5 | A |
| DYNAMIC PARAMETERS | | | | | | |
| C _{iss} | Input Capacitance | V _{GS} =0V, V _{DS} =10V, f=1MHz | | 1160 | | pF |
| C _{oss} | Output Capacitance | | | 187 | | pF |
| C _{rss} | Reverse Transfer Capacitance | | | 146 | | pF |
| R _g | Gate resistance | V _{GS} =0V, V _{DS} =0V, f=1MHz | | 1.5 | | Ω |
| SWITCHING PARAMETERS | | | | | | |
| Q _g | Total Gate Charge | V _{GS} =4.5V, V _{DS} =10V, I _D =7A | | 16 | | nC |
| Q _{gs} | Gate Source Charge | | | 0.8 | | nC |
| Q _{gd} | Gate Drain Charge | | | 3.8 | | nC |
| t _{D(on)} | Turn-On Delay Time | V _{GS} =5V, V _{DS} =10V, R _L =1.35Ω, R _{GEN} =3Ω | | 6.2 | | ns |
| t _r | Turn-On Rise Time | | | 12.7 | | ns |
| t _{D(off)} | Turn-Off Delay Time | | | 51.7 | | ns |
| t _f | Turn-Off Fall Time | | | 16 | | ns |
| t _{rr} | Body Diode Reverse Recovery Time | I _F =7A, dI/dt=100A/μs | | 17.7 | | ns |
| Q _{rr} | Body Diode Reverse Recovery Charge | I _F =7A, dI/dt=100A/μs | | 6.7 | | nC |

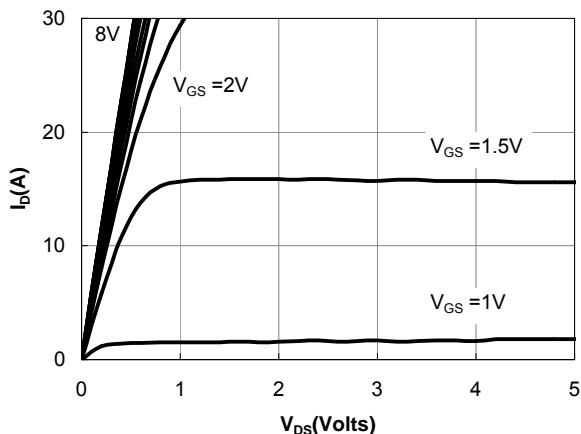
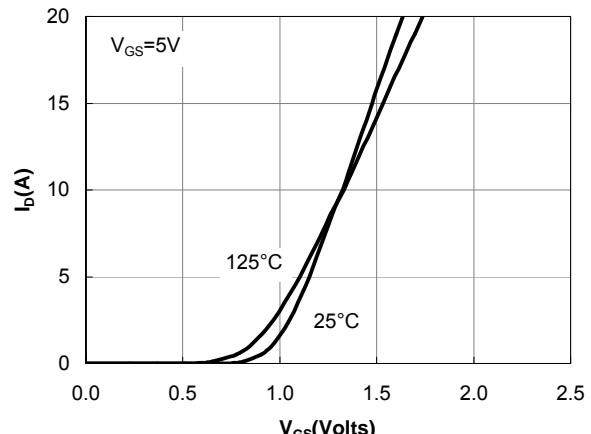
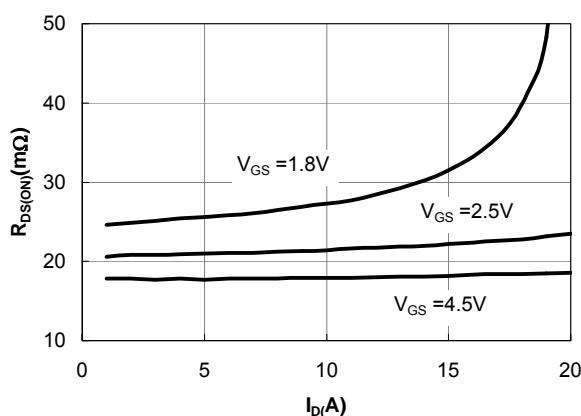
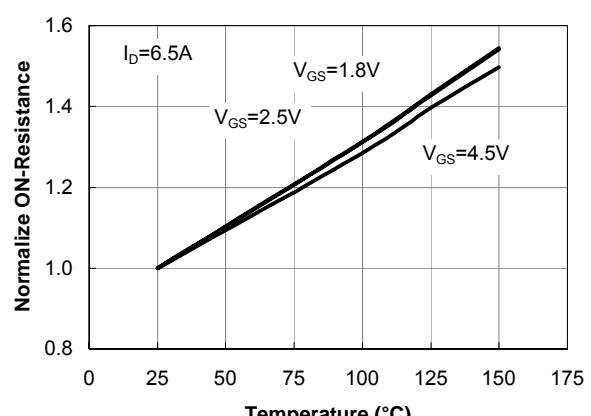
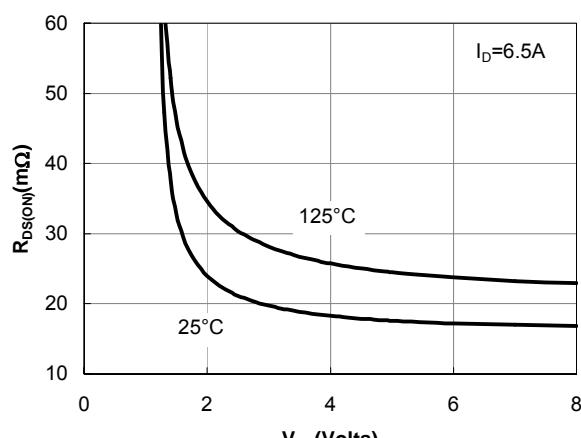
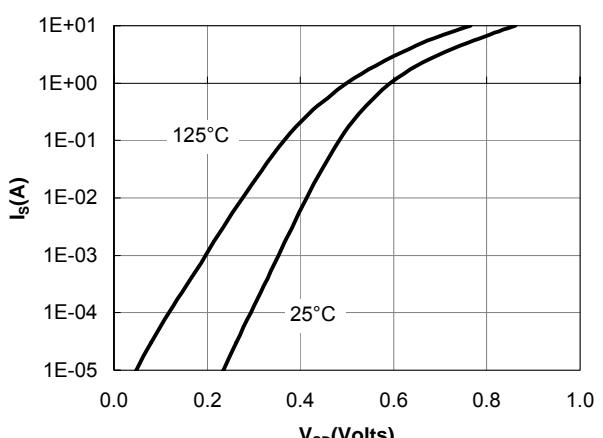
A: The value of R_{θJA} is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with T_A=25°C. The value in any given application depends on the user's specific board design. The current rating is based on the t≤ 10s thermal resistance rating.

B: Repetitive rating, pulse width limited by junction temperature.

C. The R_{θJA} is the sum of the thermal impedance from junction to lead R_{θJL} and lead to ambient.

D. The static characteristics in Figures 1 to 6,12,14 are obtained using 80μs pulses, duty cycle 0.5% max.

E. These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with T_A=25°C. The SOA curve provides a single pulse rating.

8810 Typical Characteristics

Figure 1: On-Regions Characteristics

Figure 2: Transfer Characteristics

Figure 3: On-Resistance vs. Drain Current and Gate Voltage

Figure 4: On-Resistance vs. Junction Temperature

Figure 5: On-Resistance vs. Gate-Source Voltage

Figure 6: Body-Diode Characteristics

8810 Typical Characteristics
